

Notice of References Cited	Application/Control No. 10/707,695	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner Uyen-Chau N. Le	Art Unit 2876	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,393,968	02-1995	Watanabe et al.	235/462.29
	B	US-6,547,143	04-2003	Koyanagi et al.	235/462.25
	C	US-5,451,761	09-1995	Kawai et al.	235/462.07
	D	US-5,689,103	11-1997	Watanabe et al.	235/462.12
	E	US-5,525,784	06-1996	Kawai et al.	235/437
	F	US-6,206,286	03-2001	Watanabe et al.	235/462.01
	G	US-5,502,296	03-1996	Kawai et al.	235/462.07
	H	US-5,525,785	06-1996	Kawai et al.	235/437
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 61251979 A	11-1986	Japan	YANO et al.	G06K 07/10
	O	JP 05128292 A	05-1993	Japan	GOTO, ATSUO	G06K 07/10
	P	JP 06036065 A	02-1994	Japan	KAWAI et al.	G06K 07/10
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.